

Joint ICTP-IAEA Advanced Workshop on High Sensitivity 2D & 3D  
Characterisation and Imaging with Ion Beams | (smr 2856)

Contribution ID : 15

Type : **not specified**

## Bus transfer to Synchrotron Elettra

*Wednesday, 28 September 2016 13:00 (1:00)*

### Content

Pick up from LB parking lot at 13:15

### Summary

**Session Classification :** DAY 3